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FQB27P06 / FQI27P06

60V P-Channel MOSFET

General Description

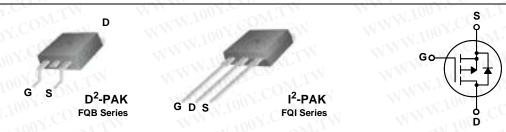
These P-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand a high energy pulse in the avalanche and commutation modes. These devices are well suited for low voltage applications such as automotive, DC/DC converters, and high efficiency switching for power management in portable and battery operated products.

Features

- -27A, -60V, $R_{DS(on)} = 0.07\Omega @V_{GS} = -10 \text{ V}$
- Low gate charge (typical 33 nC)
- Low Crss (typical 120 pF)
- Fast switching
- 100% avalanche tested
- · Improved dv/dt capability
- 175°C maximum junction temperature rating
- RoHS Compliant





Absolute Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	FQB27P06 / FQI27P06	Units
V _{DSS}	Drain-Source Voltage	-60	VO
I _D	Drain Current - Continuous (T _C = 25°C)	-27	A
	- Continuous (T _C = 100°C)	-19.1	A
I _{DM}	Drain Current - Pulsed (Note 1)	-108	A C
V_{GSS}	Gate-Source Voltage	± 25	V. V
E _{AS}	Single Pulsed Avalanche Energy (Note 2)	560	mJ
I _{AR}	Avalanche Current (Note 1)	-27	Α
E _{AR}	Repetitive Avalanche Energy (Note 1)	12	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	-7.0	V/ns
P _D	Power Dissipation (T _A = 25°C) *	3.75	W
	Power Dissipation (T _C = 25°C)	120	W
	- Derate above 25°C	0.8	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range	-55 to +175	°C
T _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	°C

Thermal Characteristics

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	TINN.E	1.25	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *	- TW-100	40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	7177 = 1007	62.5	°C/W

^{*} When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-60			V
ΔBV_{DSS} / ΔT_{J}	Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, Referenced to 25°C	M.T	-0.06		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -60 \text{ V}, V_{GS} = 0 \text{ V}$	DMF.,	~~~	-1	μΑ
		V _{DS} = -48 V, T _C = 150°C	14	7.7	-10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = -25 V, V _{DS} = 0 V		TIN	-100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = 25 \text{ V}, V_{DS} = 0 \text{ V}$	$C\bar{\sigma}_{\Sigma}$	(TV)	100	nA
On Cha	aracteristics (MANA)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	-2.0	- 1	-4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = -10 V, I _D = -13.5 A	00¥.C	0.055	0.07	Ω
9FS	Forward Transconductance	$V_{DS} = -30 \text{ V}, I_D = -13.5 \text{ A}$ (Note 4)	n e Y	12.4	TH	S
Dynam	ic Characteristics	COM. WWW.	100	I.COP	WILL	
C _{iss}	Input Capacitance	V 25 V V 20 V	- 400	1100	1400	pF
Coss	Output Capacitance	$V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz	4.70	510	660	√ pF
C _{rss}	Reverse Transfer Capacitance	Ι = 1.0 ΙΝΙΠΖ		120	155	pF
- ntt >	ing Characteristics	OY.COM.TW W	WW.	100X	CO_M	TW
t _{d(on)}	Turn-On Delay Time	V _{DD} = -30 V, I _D = -13.5 A,	4	18	45	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega$		185	380	ns
t _{d(off)}	Turn-Off Delay Time	100X.	M-5.	30	70	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		90	190	ns
Q_g	Total Gate Charge	$V_{DS} = -48 \text{ V}, I_{D} = -27 \text{ A},$	-	33	43	nC
Q _{gs}	Gate-Source Charge	V _{GS} = -10 V		6.8	100-	nC
Q_{gd}	Gate-Drain Charge	(Note 4, 5)	1	18	1001.	nC
Drain-S	Source Diode Characteristics ar	nd Maximum Ratings				
Is	Maximum Continuous Drain-Source Did	ode Forward Current		1/1	-27	Α
I _{SM}	Maximum Pulsed Drain-Source Diode F	Forward Current		44	-108	Α
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = -27 \text{ A}$		-3.3.11	-4.0	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V, } I_S = -27 \text{ A,}$ $dI_F / dt = 100 \text{ A/}\mu\text{s}$ (Note 4)		105	- N.	ns
Q _{rr}	Reverse Recovery Charge		Ň	0.41		μС
lotes: . Repetitive R . L = 0.9mH, I . $I_{SD} \le -27A$,	tating : Pulse width limited by maximum junction temper I_{AS} = -27A, V_{DD} = -25V, R_G = 25 Ω , Starting T_J = 25°C d/dt \leq 300A/µs, V_{DD} \leq BV _{DSS} , Starting T_J = 25°C Pulse width \leq 300µs, Duty cycle \leq 2%		TW	1	MM	N.10

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Notes:

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Typical Characteristics

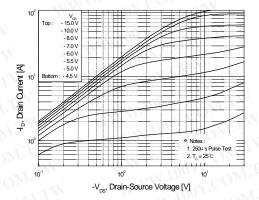


Figure 1. On-Region Characteristics

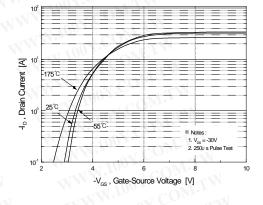


Figure 2. Transfer Characteristics

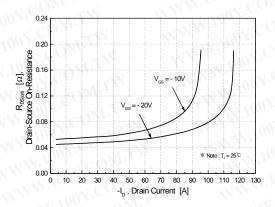


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

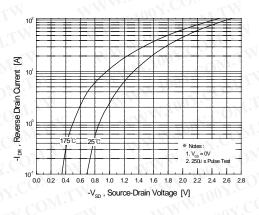


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

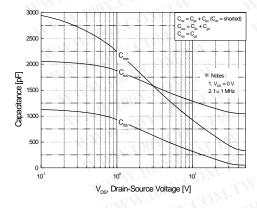


Figure 5. Capacitance Characteristics

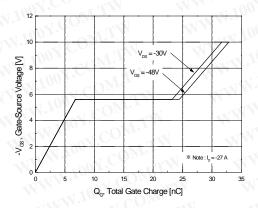
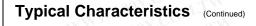


Figure 6. Gate Charge Characteristics

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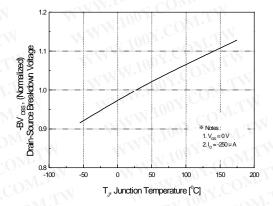


Figure 7. Breakdown Voltage Variation vs. Temperature

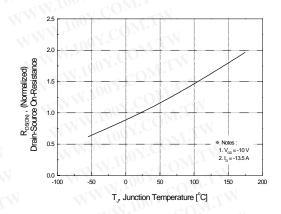


Figure 8. On-Resistance Variation vs. Temperature

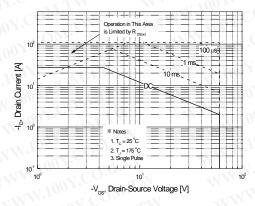


Figure 9. Maximum Safe Operating Area

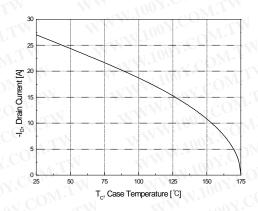


Figure 10. Maximum Drain Current vs. Case Temperature

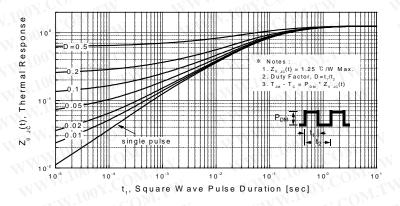
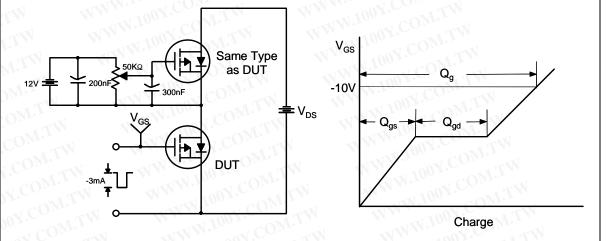


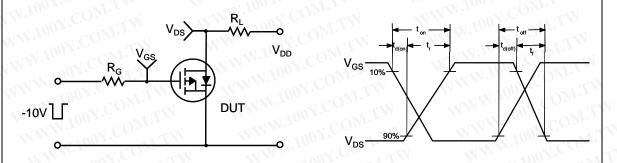
Figure 11. Transient Thermal Response Curve

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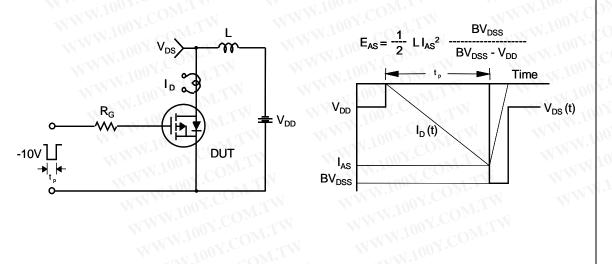
Gate Charge Test Circuit & Waveform



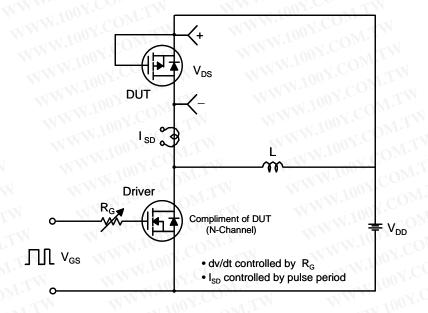
Resistive Switching Test Circuit & Waveforms

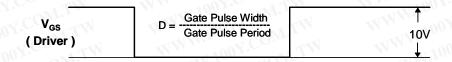


Unclamped Inductive Switching Test Circuit & Waveforms



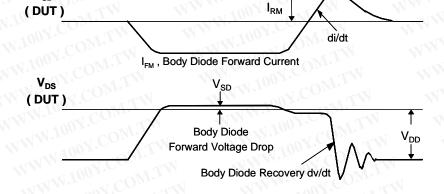
Peak Diode Recovery dv/dt Test Circuit & Waveforms



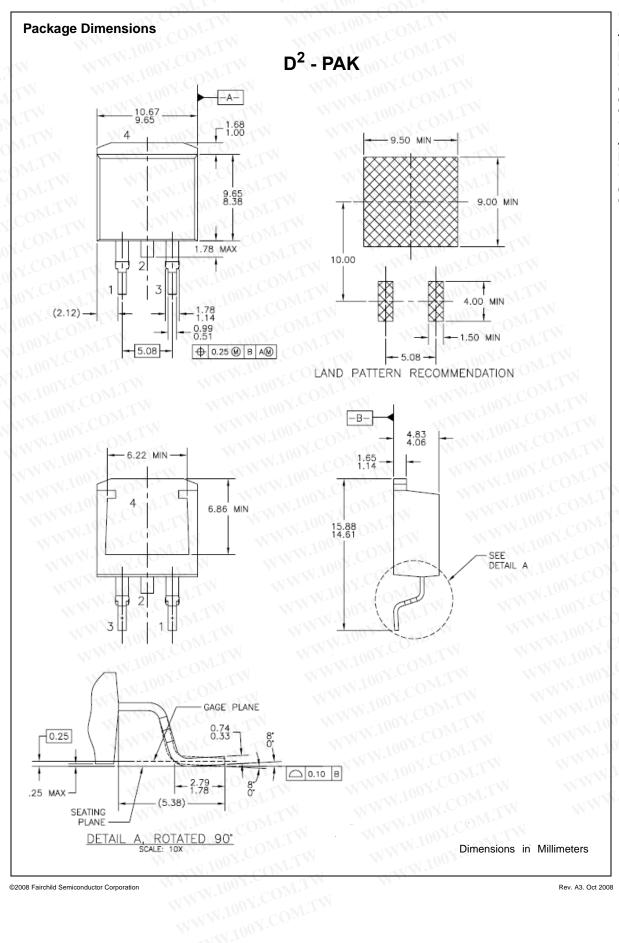


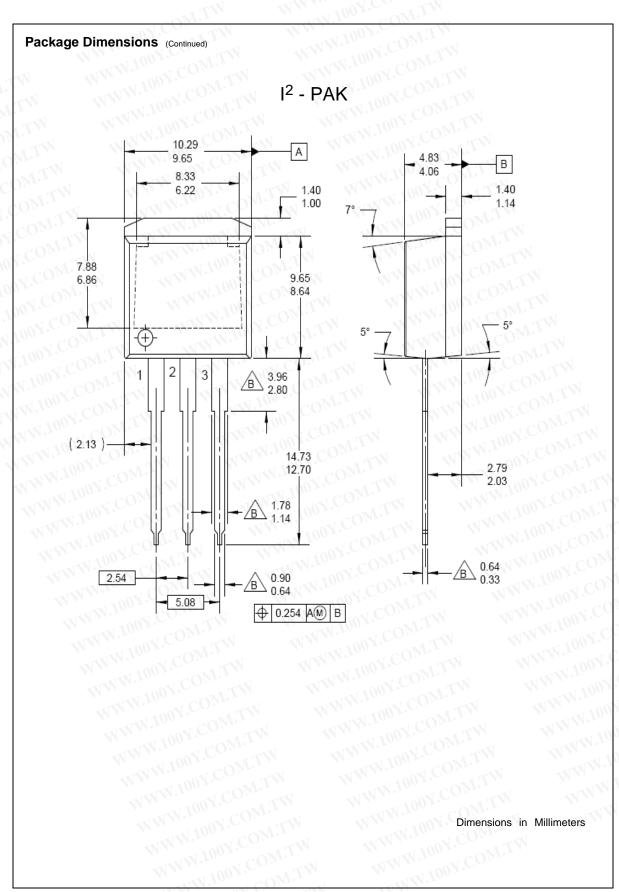
Body Diode Reverse Current

 I_{RM}



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